IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant:

Akira YOSHINO

Appl. No.:

NEW NON-PROVISIONAL

Filed:

November 20, 2003

Examiner:

Group:

For:

NONVOLATILE SEMICONDUCTOR MEMORY DEVICE

AND METHOD FOR MANUFACTURING SAME

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

November 20, 2003

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. <u>LIST OF PATENTS</u>, <u>PUBLICATIONS OR OTHER INFORMATION</u>

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO. If copies are needed, please contact the undersigned.

III. CONCISE EXPLANATION OF THE RELEVANCE (check at least one box)

a. DOCUMENTS IN THE ENGLISH LANGUAGE

The attached patents, publications, or other information in the English language do not require a statement of relevancy.

b.		DOCUM	MENTS NOT IN THE ENGLISH LANGUAGE									
		pater	oncise explanation of the relevance of all nts, publications, or other information listed is not in the English language is as follows:									
c.		FOREIGN SEARCH REPORT OR ACTION										
		An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).										
d.		OTHER										
The following additional information is provided for the Examiner's consideration.												
<u>FEES</u>												
This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.												
If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.												
			Respectfully submitted,									
			YOUNG & THOMPSON									
Benoît Castel, Reg. No. 35,041												
BC/ia			745 South 23 rd Street Arlington, VA 22202 Telephone (703) 521-2297									
Enclosure	s:	\boxtimes	Form PTO-1449(s)									
		\boxtimes	Documents									
			Foreign Search Report									
			Other:									

PTO-1449

INFO	RMATION DISCLOSU		Attorney Docket No.: 8070-1005	Application No.: NEW NONPROVISIONAL						
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(Use several sheets if necessary)					Filing Date: November 20, 2003	Group Art Unit:				
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					JANE GONGIDENED					

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

^{*} Abstract provided for the Examiner's convenience